

N&P-Channel MOSFET

General Description

The WSP6067 is the highest performance trench N-ch and P-ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSP6067 meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Product Summery

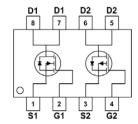
BVDSS	RDSON	ID
60V	26mΩ	6.5A
-60V	60mΩ	-4.5A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter.
- Networking DC-DC Power System
- Load Switch

SOP-8 Pin Configuration





Absolute Maximum Ratings

		Rat	ing	
Symbol	Parameter	N-Channel	P-Channel	Units
V_{DS}	Drain-Source Voltage	60	-60	V
V_{GS}	Gate-Source Voltage	±20	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	6.5	-4.5	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	4.5	-2.8	Α
I _{DM}	Pulsed Drain Current ²	24	-16	Α
EAS	Single Pulse Avalanche Energy ³	12	16	mJ
I _{AS}	Avalanche Current	16	-18	Α
P _D @T _C =25℃	Total Power Dissipation ⁴	3.1	3.1	W
T _{STG}	Storage Temperature Range	-55 to 150	-55 to 150	$^{\circ}$
T _J	Operating Junction Temperature Range	-55 to 150	-55 to 150	$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-Ambient ¹		90	°C/W
R _{θJC}	Thermal Resistance Junction-Case ¹		50	°C/W



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N-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =1mA		0.063		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =6.5A		26	36	m()
R _{DS(ON)}	Static Diain-Source On-Resistance	V _{GS} =4.5V , I _D =3A		36	45	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1	2	3	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID -230UA		-5.24		mV/℃
l	Drain-Source Leakage Current	V_{DS} =48V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55℃			5	uA_
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V_{DS} =5 V , I_{D} =8 A		21		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		3.0	4.5	Ω
Q_g	Total Gate Charge (4.5V)			14	20	
Q_{gs}	Gate-Source Charge	V_{DS} =48V , V_{GS} =4.5V , I_{D} =6.5A		2.6		nC
Q_gd	Gate-Drain Charge			2.2		
$T_{d(on)}$	Turn-On Delay Time			8		
T _r	Rise Time	V_{DD} =30V , V_{GS} =10V , R_G =6 Ω ,		6		ns
$T_{d(off)}$	Turn-Off Delay Time	I _D =1A ,R _L =6Ω		23		115
T _f	Fall Time			6		
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		670		
Coss	Output Capacitance			70		pF
C _{rss}	Reverse Transfer Capacitance			35		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =16A	11.2			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
I _S	Continuous Source Current ^{1,6}	-V _G =V _D =0V , Force Current			2.5	Α
I _{SM}	Pulsed Source Current ^{2,6}				24	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1.7A,T _J =25℃			1.1	V

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10 sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V,L=0.1mH, I_{AS} =16A
- 4.The power dissipation is limited by 150 °C junction temperature
- 5.The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



N&P-Channel MOSFET

P-Channel Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-60			V
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25℃, I _D =-1mA		-0.03		V/°C
D	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-4.5A		60	75	
R _{DS(ON)}	Static Dialii-Source On-Resistance	V _{GS} =-4.5V , I _D =-1A		75	85	mΩ
V _{GS(th)}	Gate Threshold Voltage	V _{GS} =V _{DS} . In =-250uA	-1.5	-2.0	-2.5	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250UA		4.56		mV/℃
	Drain-Source Leakage Current	V _{DS} =-48V , V _{GS} =0V , T _J =25°C			1	uA
I _{DSS}	Diain-Source Leakage Current	V_{DS} =-48V , V_{GS} =0V , T_J =55 $^{\circ}$ C			5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-4.5A		18		S
R_g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.5	2.7	Ω
Qg	Total Gate Charge (-4.5V)			12		
Q_gs	Gate-Source Charge	V _{DS} =-48V , V _{GS} =-10V , I _D =-4.5A		1.5		nC
Q _{gd}	Gate-Drain Charge			3.0		
T _{d(on)}	Turn-On Delay Time			7.5		
Tr	Rise Time	V_{DD} =-30V , V_{GS} =-10V , R_{G} =6 Ω ,		4.5		
T _{d(off)}	Turn-Off Delay Time	I _D =-1A,R _L =30Ω.		38		ns
T _f	Fall Time			28		
C _{iss}	Input Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		500		
Coss	Output Capacitance			66		pF
C _{rss}	Reverse Transfer Capacitance			32		

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =-25V , L=0.1mH , I _{AS} =-18A	11			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,6}	−V _G =V _D =0V , Force Current			-1	Α
I _{SM}	Pulsed Source Current ^{2,6}				-18	Α
V_{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25℃			-1.1	V

Note

- 1.The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-18A
- 4.The power dissipation is limited by 150℃ junction temperature
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



N-Channel Typical Characteristics

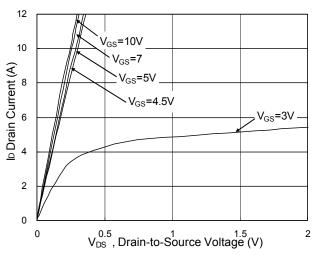


Fig.1 Typical Output Characteristics

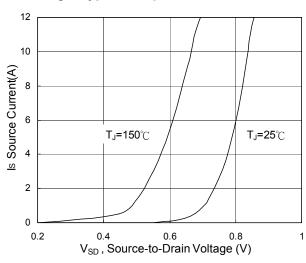


Fig.3 Forward Characteristics of Reverse

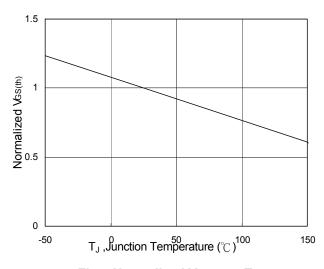


Fig.5 Normalized $V_{GS(th)}$ v.s T_J

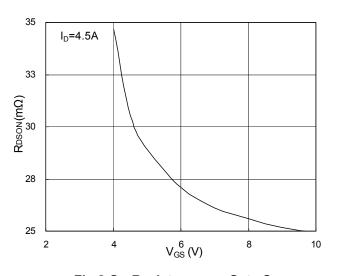


Fig.2 On-Resistance v.s Gate-Source

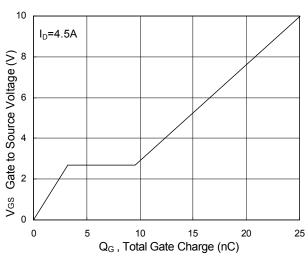


Fig.4 Gate-Charge Characteristics

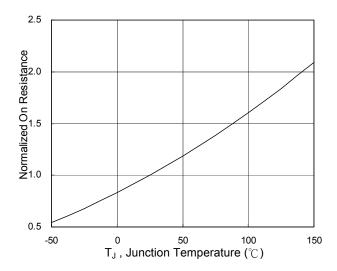
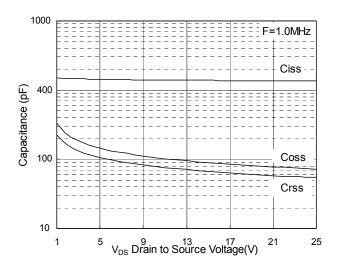


Fig.6 Normalized R_{DSON} v.s T_J







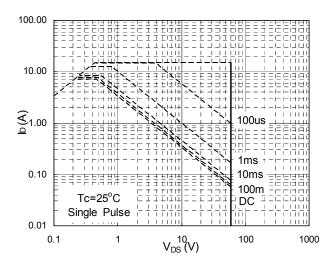


Fig.7 Capacitance

Fig.8 Safe Operating Area

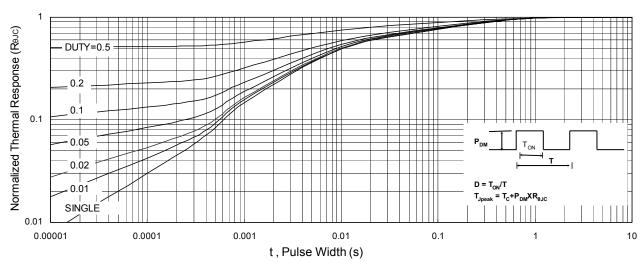


Fig.9 Normalized Maximum Transient Thermal Impedance

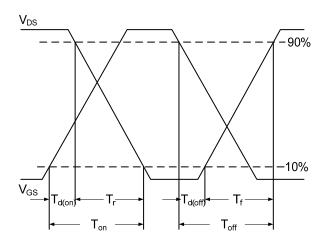


Fig.10 Switching Time Waveform

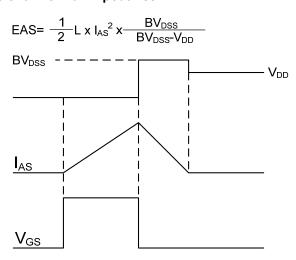


Fig.11 Unclamped Inductive Waveform



P-Channel Typical Characteristics

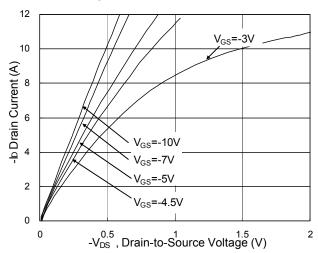


Fig.1 Typical Output Characteristics

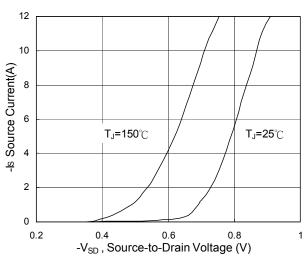


Fig.3 Forward Characteristics of Reverse

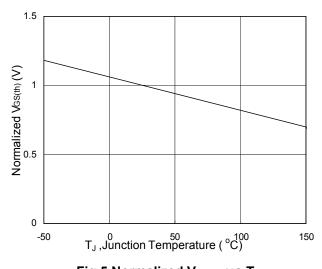


Fig.5 Normalized $V_{\text{GS}(\text{th})}$ v.s T_{J}

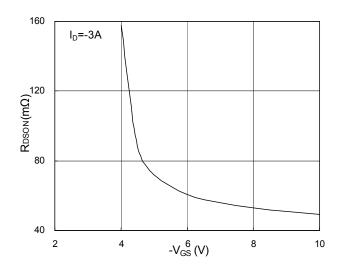


Fig.2 On-Resistance v.s Gate-Source

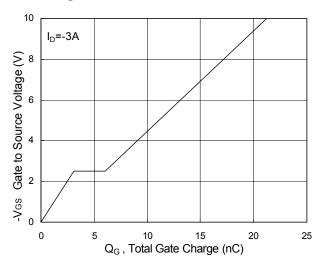


Fig.4 Gate-Charge Characteristics

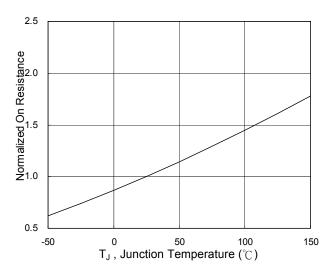
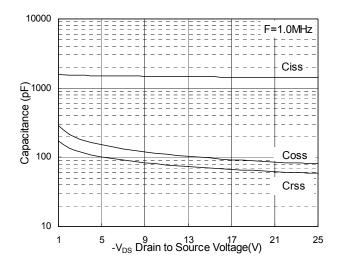


Fig.6 Normalized R_{DSON} v.s T_J





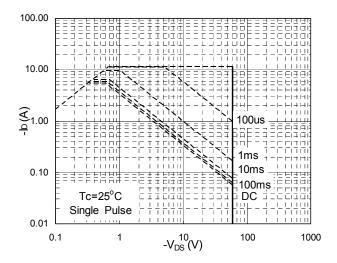


Fig.7 Capacitance

Fig.8 Safe Operating Area

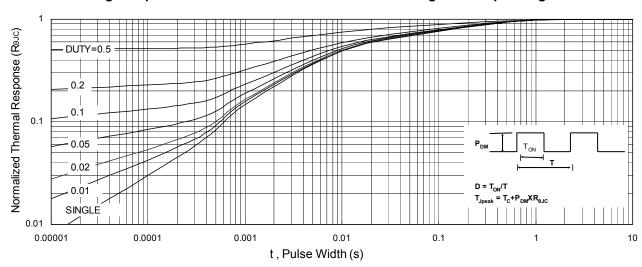


Fig.9 Normalized Maximum Transient Thermal Impedance

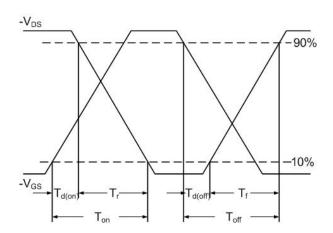


Fig.10 Switching Time Waveform

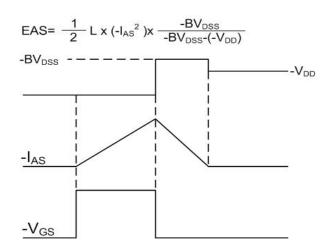


Fig.11 Unclamped Inductive Waveform



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